

Title (en)
MICROSCOPE INSPECTION SYSTEM

Title (de)
MIKROSKOPISCHES PRÜFSYSTEM

Title (fr)
SYSTEME D'INSPECTION DE MICROSCOPE

Publication
EP 1290484 A2 20030312 (EN)

Application
EP 01929949 A 20010510

Priority
• IL 0100410 W 20010510
• US 57097200 A 20000515

Abstract (en)
[origin: WO0188592A2] An electrical circuit inspection system including an eyepiece operative to collimate light received from a portion of interest in an electrical circuit, a zoom and/or automatic focus video camera assembly receiving collimated light from the eyepiece and a display operative to receive a video output from the zoom video camera and to display a magnified image of the portion of interest.

IPC 1-7
G02B 21/00

IPC 8 full level
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CPC (source: EP)
G02B 21/0016 (2013.01); **G02B 21/361** (2013.01)

Citation (search report)
See references of WO 0188592A2

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WO 0188592 A2 20011122; WO 0188592 A3 20020815; AU 5662401 A 20011126; EP 1290484 A2 20030312; IL 152640 A0 20040219; JP 2003533731 A 20031111; TW 468033 B 20011211

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IL 0100410 W 20010510; AU 5662401 A 20010510; EP 01929949 A 20010510; IL 15264001 A 20010510; JP 2001584927 A 20010510; TW 89110322 A 20000529